

# Bent Pin Analysis

Methodology and Best Practices

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# Challenges

- Smaller fuzes
  - Higher pin density
  - Less space for connectors
  - Example different “D-Sub” families
- Considerations
  - Safety – Prevent arming sequence progression
  - Reliability – Minimize number of mission failures
  - Testability – Interface to arm w/o environments
- Analysis
  - Deciding on number of connectors
  - Which connections to analyze
  - Assigning pins
  - Determining the effect

Traditional  
(MIL-DTL-24308)  
Pitch ~0.10in



L717DE09PST



L77DE09SST

50% pitch

Micro  
(MIL-DTL-83513)  
Pitch .050in



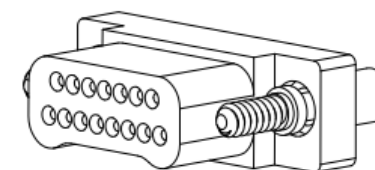
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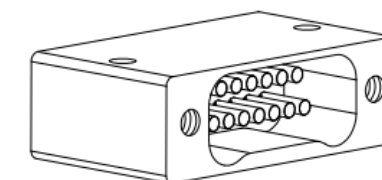
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50% pitch

Nano  
(MIL-DTL-32139)  
Pitch .025in



STL00911500PCN



STL00911500SCN

Connector images from Digikey

**Smaller Fuzes Increase Challenges that Methodical Analysis can Address**

# Considerations for Connector(s) in Design

- Requirement flow down
  - JOTP-053 Section 5.1.8 Shorting of I/O (Electrical Stress Test)
  - Test where analysis cannot predict output
  - Criteria for analysis not defined
- Order of preference – no perfect option
  1. Only assign signals necessary for the fuze to function
  2. Assign test signals to a separate connector
  3. Single connector w/ test signals/functional signals & mitigations
- Option 3 is often preferred choice
  - Connectors are large components
  - Can be some of the most expensive components
  - Long lead times
  - Mitigations can be designed to reduce safety impact

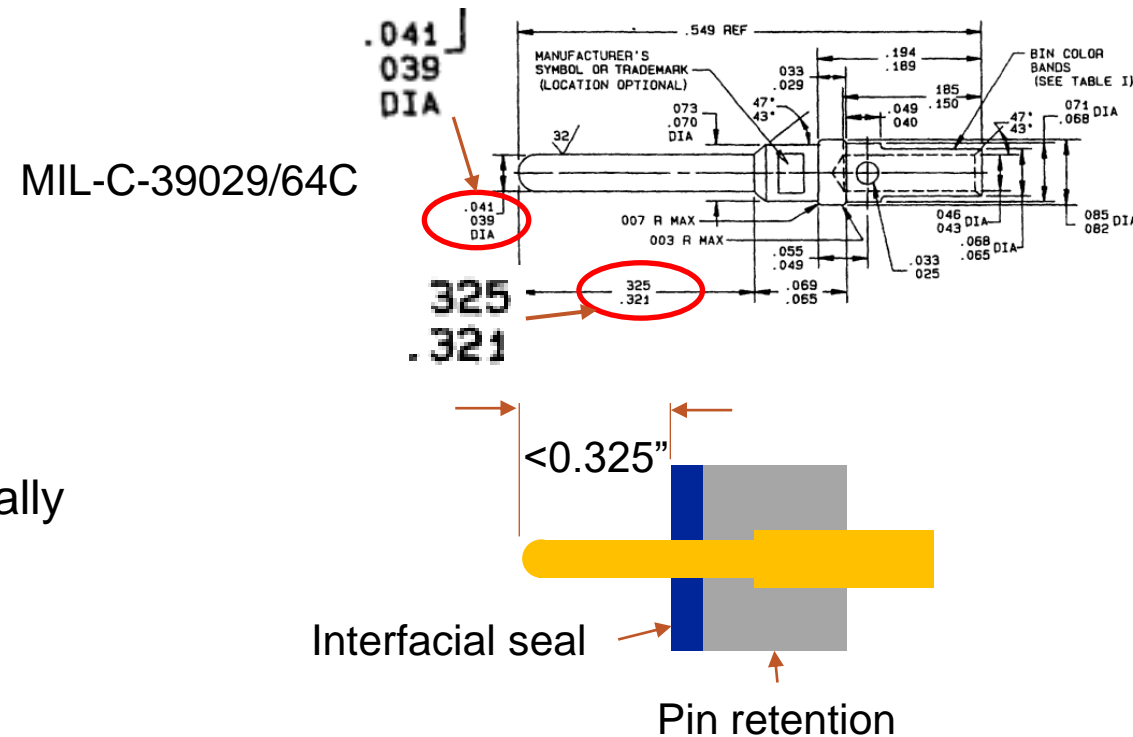
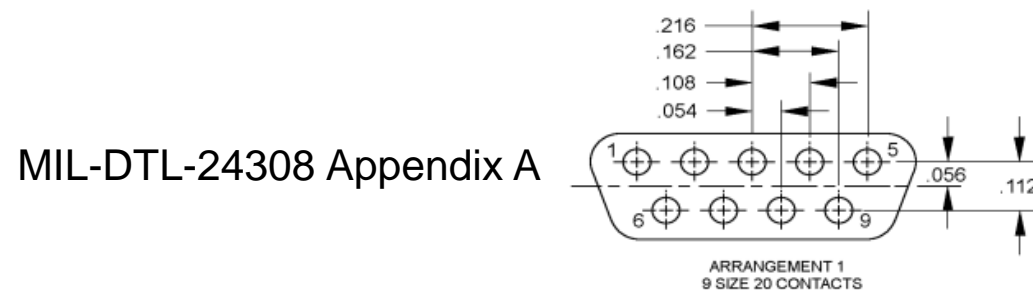
- Testability mitigation examples
  - Isolating test signals with no connects/grounds
  - Unique signals (level/pattern)
  - Omitting signals in system wiring
  - Multiple Inputs

Preference	Safety	Design Complexity	Testability
1. Only Functional Signals	Green	Green	Red
2. Two Connectors	Yellow	Red	Green
3. Single Conn w/ Mitigations	Yellow	Yellow	Green
4. Single Conn w/o Mitigations	Red	Yellow	Green

**Intentional Design Principles Needed to Ensure Safety and Testability Needs are Met in System Footprint**

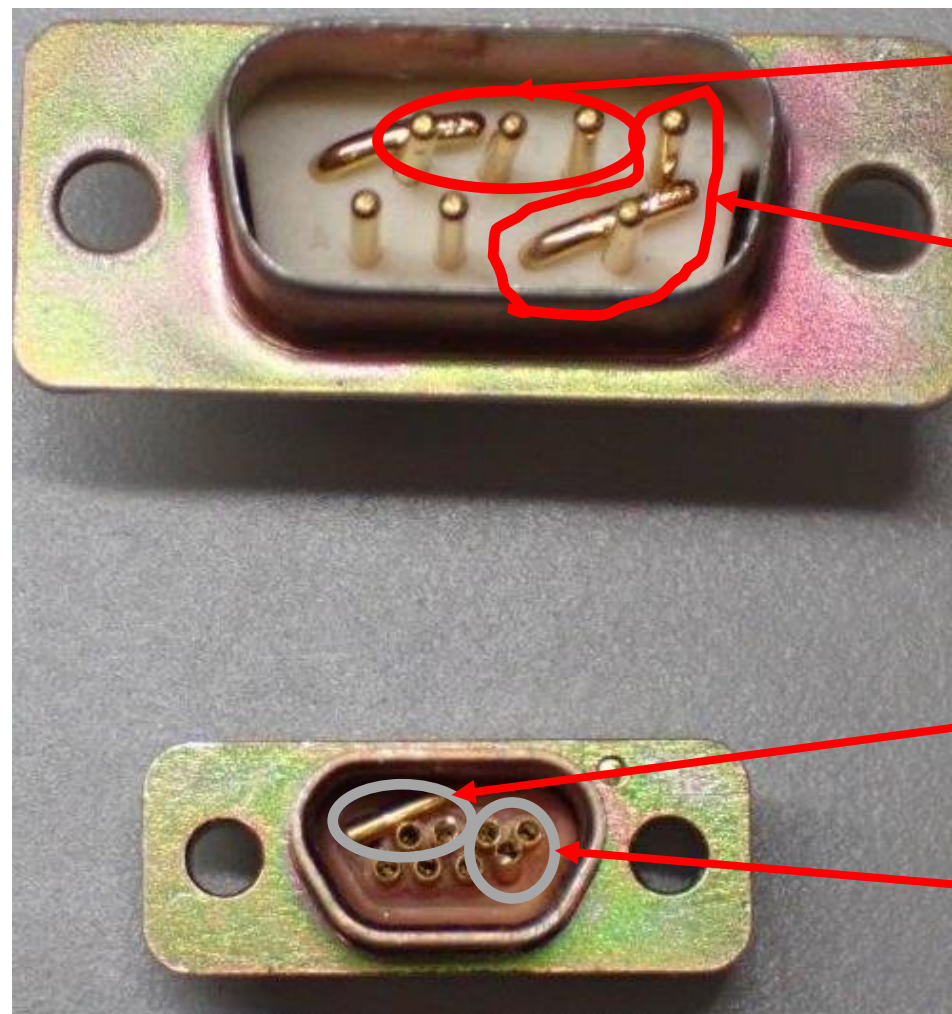
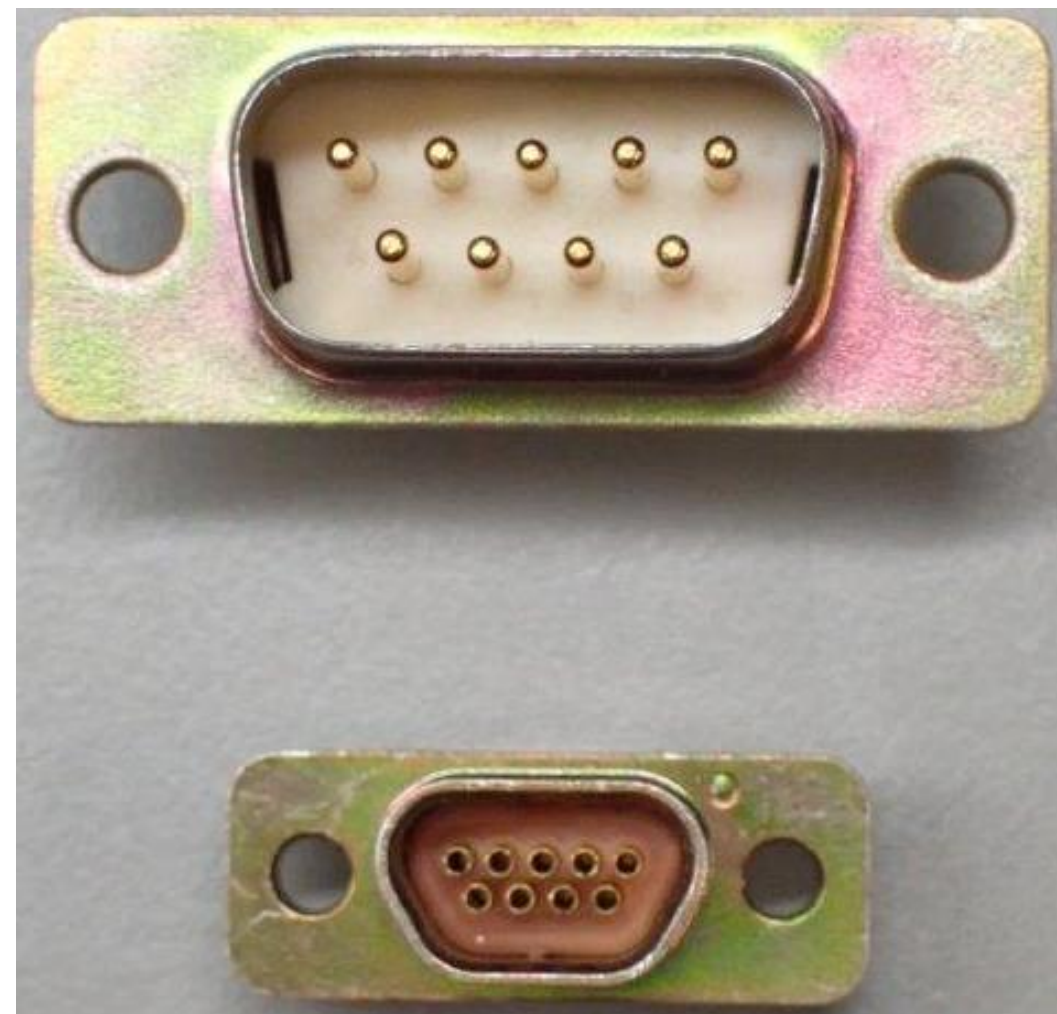
## Pins Combinations to Analyze

- Which pins can be contacted
  - Dimensions to consider
    - Pin spacing/length/diameter
    - Interfacial seal/insulation/retention dimensions
  - Dimensions can be hard to find work with supplier
  - Just pin length can be overly conservative
  - Multiple pins possible
  - Don't forget shell
- Observations about example
  - Pin 3 is long enough to contact all pins depending on length of pin retention material
  - Multiple pins can be contacted horizontally and diagonally



**Consideration of Pin/Connector Interface Required to Determine Number of Contacts**

## Pins Combinations to Analyze



1 – 2 pins close 3<sup>rd</sup>

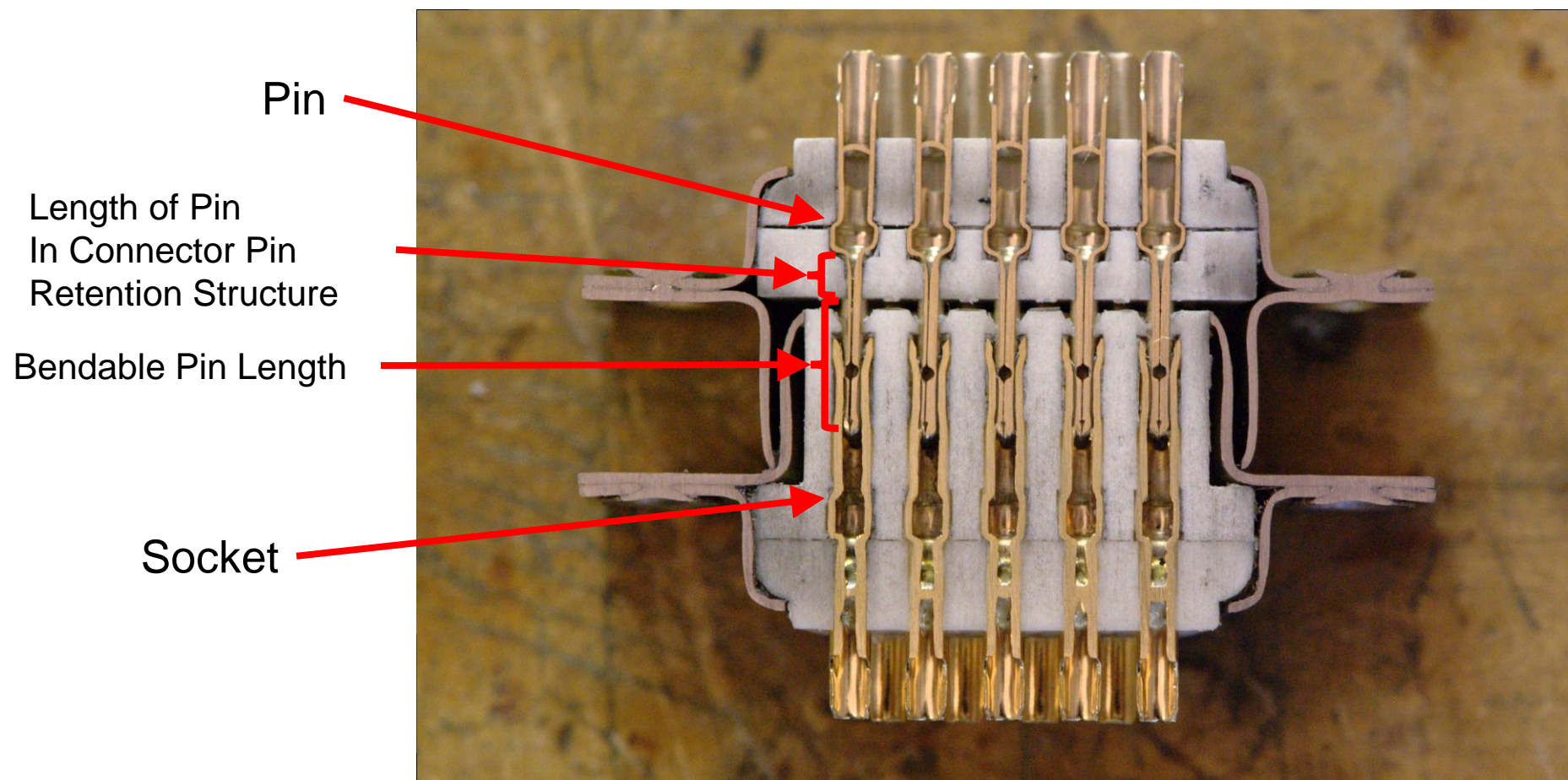
2 – 3 pins

3 – 3 pins

4 – 3 pins

**Muti Pin Contact Can be Contacted in Multiple Orientations**

## Pins Combinations to Analyze – Mated Pair Cross Section

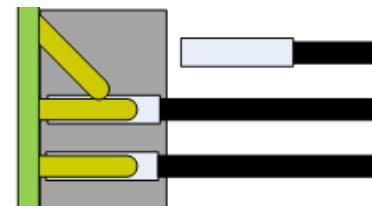


See Citation for Picture at End of Presentation

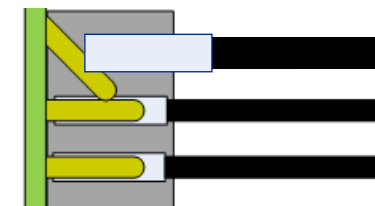
**Understanding the Structure of the Connector Is Necessary to Determine Bendable Pin Length**

# Signal Analysis

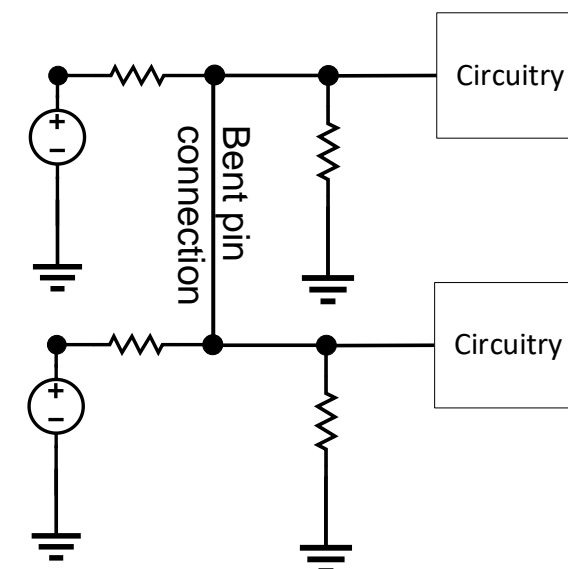
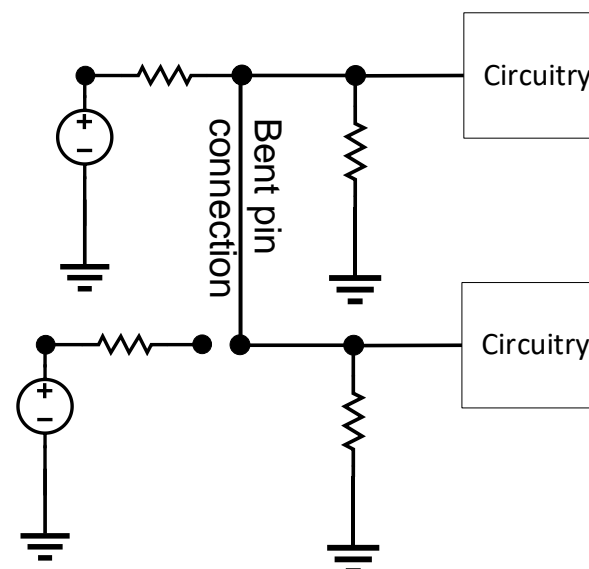
- Two sets
  - Connected to own socket
  - Not connected to own socket
- Types
  - Loads – Pulled down
  - Sources/Loads Pulled up
- Understand combinations of circuits
  - Extra sources – bus contention/voltage levels
  - Extra loads – thresholds/pull down source
  - Extra sources and loads
  - Multi-pin contact combinations



Without Connection to Own Socket

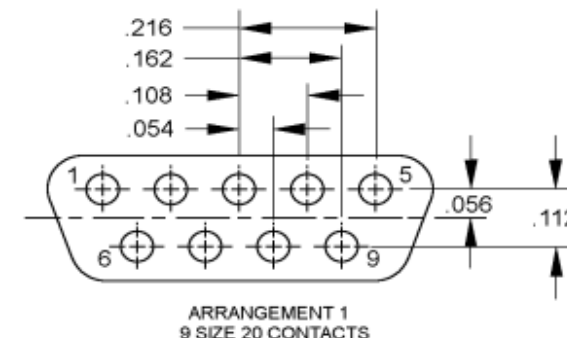


With Connection to Own Socket



## Picking Pin Assignments

- Understand which pins can contact
- Characteristics of signals at connector/how circuits interact
- Mission Phase
  - Pre-commit (e.g., communications power, external firing, umbilical)
  - Post-commit (arming power, status lines)
- Functionality
  - Power
  - Sensor or event (eg umbilical)
  - Status
  - Test
- Group Signals Best Practice
  - Separate Pre-commit/post commit to limit back drive risk
  - Pay special attention to sensor/event combinations
  - Ensure test signals cannot be driven to an active state by bent pin combinations
  - Grounds can be effective assignments for challenging locations



**Connector Geometry, Signal Characteristics, and Signal Usage Provide Information Needed to Assign Pins**



## Analysis Output

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- Safety Impacts
  - Ensure environment is sensor input not validated
  - Ensure environment is not bypassed
- Reliability Impacts
  - Degraded functionality (Modes/features)
  - Loss of mission (Shorts/Loss of Arming)
- Results
  - Fuze Level
    - Update design interface to tolerate bent pin
  - System Level
    - Factory access connectors for mission critical signals
    - System/sub-system level resistance checks

**Verify No Safety Faults, Minimize Reliability Impacts via Design and System Test**

## Takeaways

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- Smaller systems are driving pin pitch/size smaller
- Balance safety, reliability, and testability when designing a fuze connection interface
- Determining which pins can contact requires detailed information about connector construction
- Signal categorization and analysis identifies most sensitive interfaces
- Assign pins to prevent safety faults first, reliability impact second
- Use analysis results to aid in system testability

**Smaller Fuzes Increase Challenges that Methodical Analysis can Address**

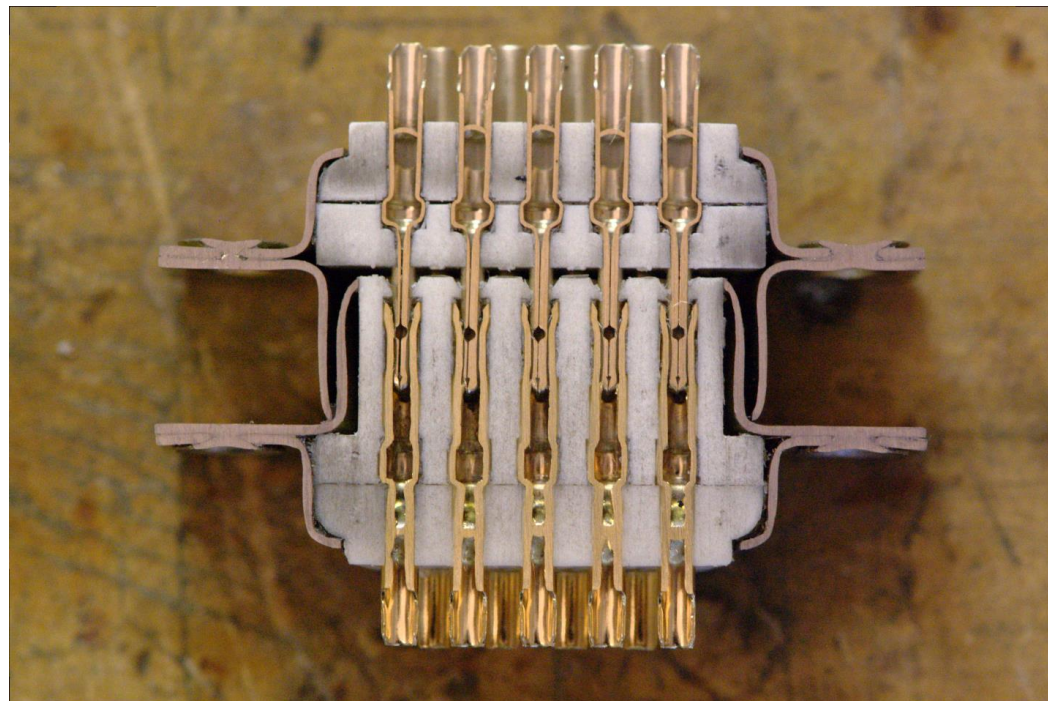


**Questions?**



# Citations

# Citation



License	Author	Source	Description/Link
<a href="#">Creative Commons Attribution-Share Alike 4.0 International</a>	TubeTimeUS	Own Work	<a href="#">Cross section of 9 pin connector</a>

**NORTHROP**  
**GRUMMAN**

The logo graphic consists of a thick black horizontal line extending from the end of the word "NORTHROP" to the right, and a thick black vertical line extending downwards from the end of the word "GRUMMAN" to the right, forming an L-shaped corner.